

**Notice of References Cited**

Application/Control No.

10/785,404

Applicant(s)/Patent Under

Reexamination

LEE, SANG-HAK

Examiner

OLUWASEUN A. ADEGEYE

Art Unit

2621

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,580,462	06-2003	Inoue et al.	348/460
*	B US-7,030,930	04-2006	Kovacevic, Branko D.	348/515
*	C US-2003/0192058	10-2003	Miyatake et al.	725/115
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
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**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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